

SPECIFICATION FOR APPROVAL

CUSTOMER :	Shenzhen Viatom Technology Co., Ltd.
CUSTOMER'S P/N :	/
PART NUMBER :	WAN8010F245H05
DESCRIPTION :	Chip Antenna 8010 M-Ant 2.4~2.5G Type H05
VERSION :	V1.1
ISSUE DATE :	2021/03/03

CUSTOMER APPROVED			

R&D CENTER					
APPROVAL CHECKED DRAWN					
Ray	Tennyson	Snow			

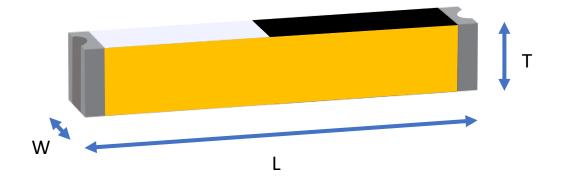


OneWave Electronic Co., Ltd.

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8010 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN8010F245H05

	Dimension (mm)		
L	8.01 ± 0.20		
W	1.03 ± 0.20		
Т	1.25 ± 0.20		

Part Number Information

W	AN	<u>8010</u>	<u> </u>	<u>245</u>	<u>H</u>	<u>05</u>
	Α	В	С	D	Ε	F
Α	A Product Series Antenna					
В	Dimension L x W		8.0X1.0mm (+-0.2mm)		.2mm)	
С	Material		Hig	h K matei	rial	
D	Wo	rking Frequ	ng Frequency 2.4 ~ 2.5GHz		lz	
Е	Feeding mode		ode Monopole & Single Feeding		e Feeding	
F	ł	Antenna type		Туре = 05		

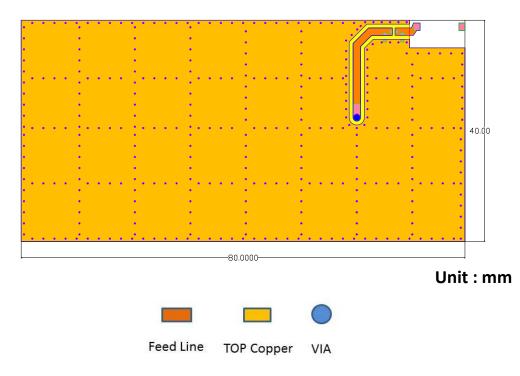
1. Electrical Specification

Specification					
Part Number WAN8010F245H05					
Central Frequency	2450	MHz			
Bandwidth	100 (Min.)	MHz			
Return Loss	-10 (Max)	dB			
Peak Gain	3.53	dBi			
Impedance	50	Ohm			
Operating Temperature	-40~+110	°C			
Maximum Power	4	W			
Resistance to Soldering Heats	10 (@ 260°C)	sec.			
Polarization Linear					
Azimuth Beamwidth	th Omni-directional				
Termination	Termination Cu / Sn (Leadless)				

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

2. Recommended PCB Pattern

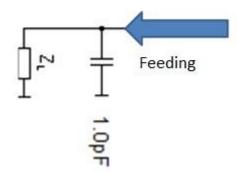
Evaluation Board Dimension



Suggested Matching Circuit

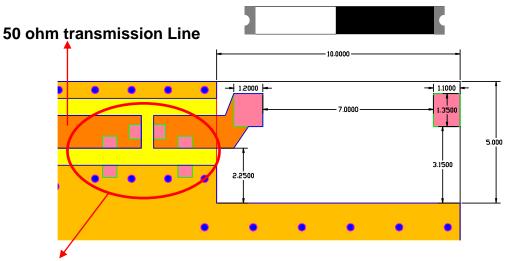
<u>重要資訊:</u>

匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



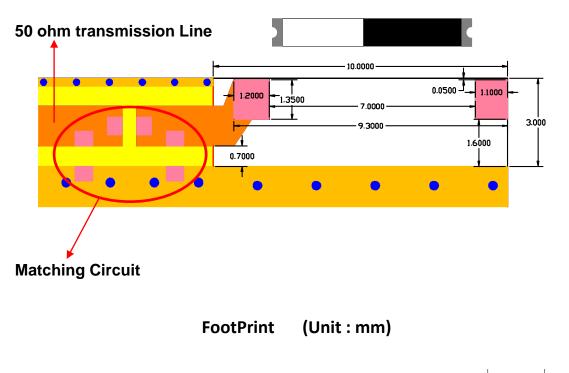


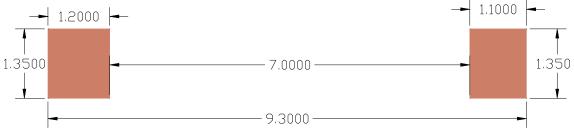




Matching Circuit

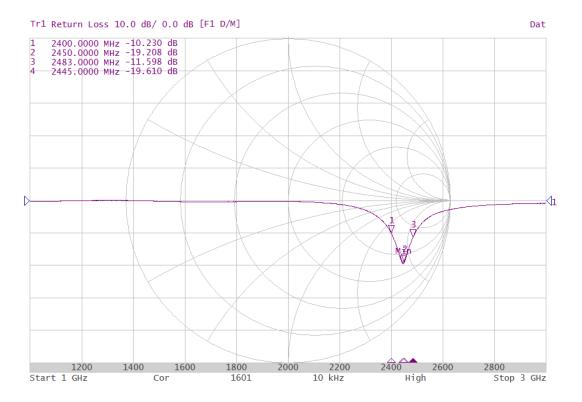
Layout Dimensions in Clearance area(Size=10.0*3.0mm)

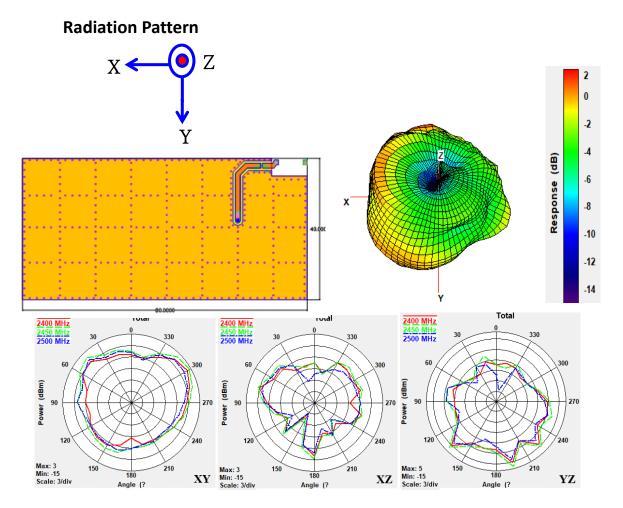




3. Measurement Results

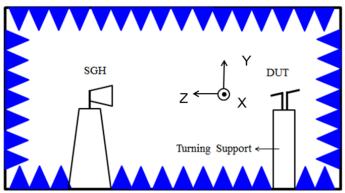
Return Loss





	Efficiency	Peak Gain	Directivity
2400MHz	69.25 %	3.41 dBi	5.42 dBi
2450MHz	75.82 %	3.53 dBi	5.38 dBi
2500MHz	68.55 %	3.26 dBi	5.17 dBi

Chamber Coordinate System



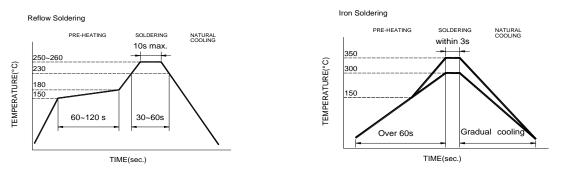


4. Reliability and	Test Condictions
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ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	1. Wetting shall exceed 90% coverage 2. No visible mechanical damage TEMP (°C) 230°C 150°C 60sec	Pre-heating temperature:150°C/60sec. Solder temperature:230±5°C Duration:4±1sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
Solder heat Resistance	1. No visible mechanical damage 2. Central Freq. change :within $\pm 6\%$ TEMP (°C) 260°C 150°C 150°C	Pre-heating temperature:150°C/60sec. Solder temperature:260±5°C Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
Component Adhesion (Push test)	1. No visible mechanical damage	The device should be reflow soldered($230\pm5^{\circ}$ C for 10sec.) to a tinned copper substrate A dynometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination attached to component.		
Component Adhesion (Pull test)	1. No visible mechanical damage	Insert 10cm wire into the remaining open eye bend ,the ends of even wire lengths upward and wind together. Terminal shall not be remarkably damaged.		
Thermal shock	1. No visible mechanical damage2. Central Freq. change :within $\pm 6\%$ PhaseTemperature(°C)Time(min)1 $\pm 110\pm 5^{\circ}C$ 30 ± 3 2RoomWithinTemperature $3sec$ 3 $-40\pm 2^{\circ}C$ 30 ± 3 4RoomWithinTemperature $3sec$	+110 \degree C =>30±3min -40 \degree C =>30±3min Test cycle:10 cycles The chip shall be stabilized at normal condition for 2~3 hours before measuring.		
Resistance to High Temperature	 No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit. 	Temperature: +110±5℃ Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.		
Resistance to Low Temperature	 No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit. 	Temperature:-40±5℃ Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.		
Humidity	 No visible mechanical damage Central Freq. change :within ±6% No disconnection or short circuit. 	Temperature: 40±2°C Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring.		

5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

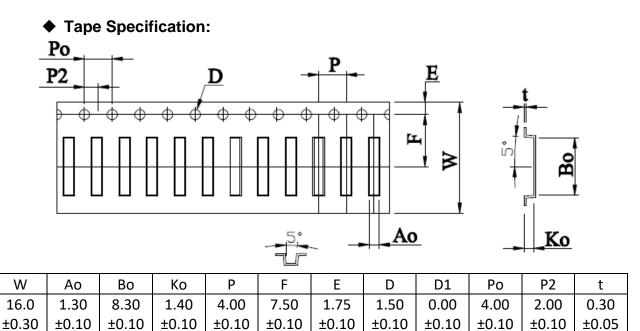


Recommended temperature profiles for re-flow soldering in Figure 1.

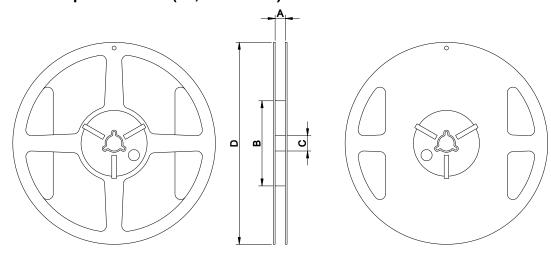
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to $150^\circ C$
- · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

6.Packaging Information



Rool S	pecification:	(7"	ወ180 mm)
Reel S	pecification.	(1,	Ψ 100 mm)



7" x 16 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
16	16±1.0	60±2	13.5±0.5	178±2	3000

7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40 $^\circ \! \mathbb{C}$ and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.